


<b>Search Notes</b>  	<b>Application/Control No.</b>  10567021	<b>Applicant(s)/Patent Under Reexamination</b>  LANGE ET AL.
	<b>Examiner</b>  Taeyoon Kim	<b>Art Unit</b>  1651

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search	4/9/2009	TK
Inventor search	6/11/2009	TK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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